MSKSEMI 美森科













ESD

1/5

TSS

MOV

GDT

PLED

ESD9B5VD-MS

Product specification





Features

- 80W peak pulse power per line (tp = 8/20µs)
- SOD-923 package
- Replacement for MLV(0402)
- Bidirectional configurations
- Response time is typically < 1ns
- Low clamping voltage
- RoHS compliant
- Transient protection for data lines to IEC61000-4-2(ESD) ±30KV(air), ±30KV(contact); IEC61000-4-4 (EFT) 40A (5/50ns)

Mechanical Characteristics

- Lead finish:100% matte Sn(Tin)
- Mounting position: Any
- Qualified max reflow temperature:260 °C
- Device meets MSL 1 requirements
- Pure tin plating: 7 ~ 17 um
- Pin flatness:≤3mil

Applications

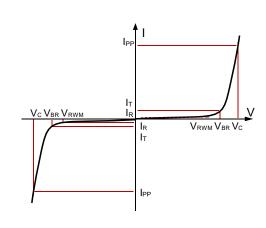
- Cellular phones
- Portable devices
- Digital cameras
- Power supplies

Reference News

SOD-923	PIN Configuration	Marking		
WEIFER!		C*		

Electronics Parameter

Symbol	Parameter		
VRWM	Peak Reverse Working Voltage		
l _R	Reverse Leakage Current @ VRWM		
V _{BR}	Breakdown Voltage @ I⊤		
lτ	Test Current		
I PP	Maximum Reverse Peak Pulse Current		
Vc	Clamping Voltage @ IPP		
P _{PP}	Peak Pulse Power		
CJ	Junction Capacitance		
lF	Forward Current		
VF	Forward Voltage @ IF		





Electrical characteristics per line@25℃ (unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Peak Reverse Working Voltage	VRWM				5	V
Breakdown Voltage	V _{BR}	l _t = 1mA	5.6	6.7	7.8	V
Reverse Leakage Current	l _R	V _{RWM} = 5V T=25℃			1.0	μΑ
Maximum Reverse Peak Pulse Current	I PP			5		А
Clamping Voltage	Vc	I _{PP} =1A			8	V
Clamping Voltage	Vc	I _{PP} =3A			13	V
Clamping Voltage	Vc	I _{PP} =5A			15	V
Junction Capacitance	Cj	V _R =0V f = 1MHz		12	15	pF

Absolute maximum rating@25℃

Rating	Symbol	Value	Units
Peak Pulse Power (t _p =8/20μs)	P _{pp}	80	W
Operating Temperature	TJ	-55 to +150	${\mathbb C}$
Storage Temperature	Тѕтс	-55 to +150	$^{\circ}$

Typical Characteristics



Fig 1.Pulse Waveform

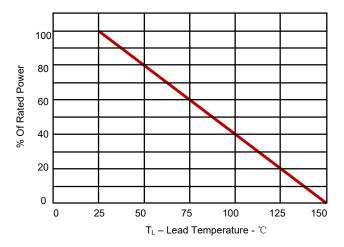


Fig 2.Power Derating Curve



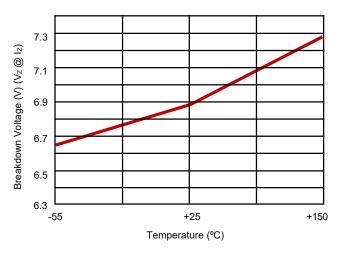


Fig 3.Typical Breakdown Voltage vs. Temperature

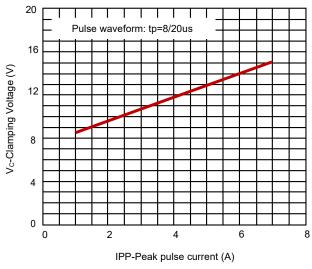
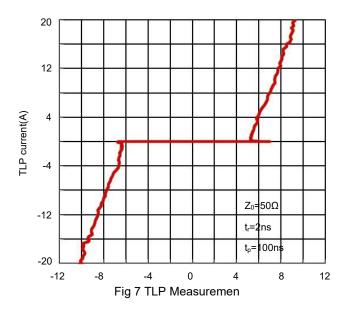


Fig 5. Clamping voltage vs. Peak pulse current



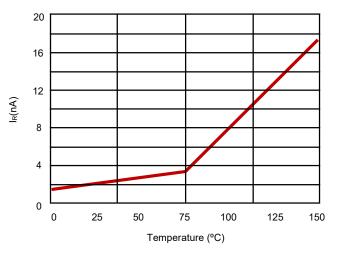


Fig 4. Typical Leakage Current vs. Temperature

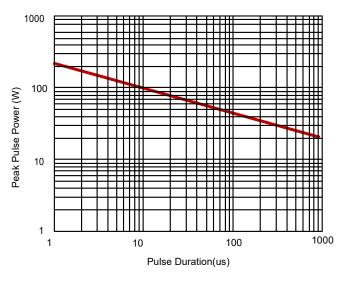
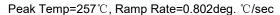
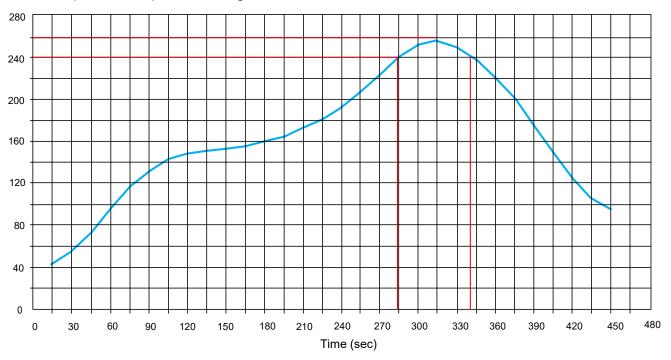


Fig 6. Non-Repetitive Peak Pulse Power vs. Pulse time



Solder Reflow Recommendation





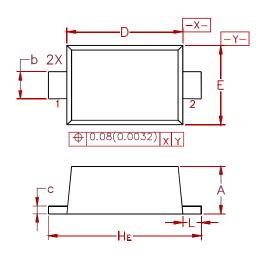
PCB Design

For TVS diodes a low-ohmic and low-inductive path to chassis earth is absolutely mandatory in order to achieve good ESD protection. Novices in the area of ESD protection should take following suggestions to heart:

- Do not use stubs, but place the cathode of the TVS diode directly on the signal trace.
- Do not make false economies and save copper for the ground connection.
- Place via holes to ground as close as possible to the anode of the TVS diode.
- Use as many via holes as possible for the ground connection.
- Keep the length of via holes in mind! The longer the more inductance they will have.

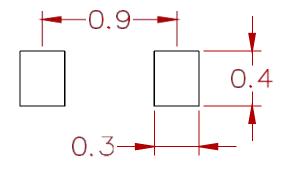


PACKAGEMECHANICALDATA



D:	Millimeters			Inches		
Dim	Min	Nom	Max	Min	Nom	Max
Α	0.36	0.40	0.43	0.014	0.016	0.017
b	0.15	0.20	0.25	0.006	0.008	0.010
С	0.07	0.12	0.17	0.003	0.005	0.007
D	0.75	0.80	0.85	0.030	0.031	0.033
E	0.55	0.60	0.65	0.022	0.024	0.026
HE	0.95	1.00	1.05	0.037	0.039	0.041
L	0.05	0.10	0.15	0.002	0.004	0.006

Suggested Pad Layout



Dimensions: Millimeters

Order information

Orderable Device	Package	Packing Option
ESD9B5VD-MS	SOD-923	8000PCS



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